## TOSHIBA

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC74VHC10F,TC74VHC10FN,TC74VHC10FT

#### Triple 3-Input NAND Gate

The TC74VHC10 is an advanced high speed CMOS 3-INPUT NAND GATE fabricated with silicon gate C<sup>2</sup>MOS technology.

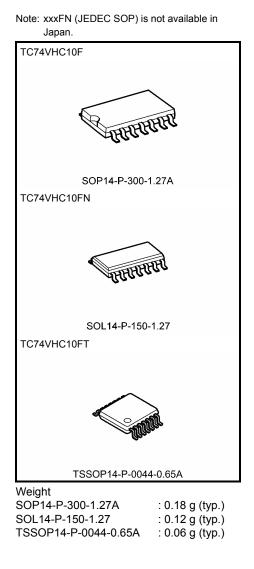
It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

The internal circuit is composed of 3 stages including buffer output, which provide high noise immunity and stable output.

An input protection circuit ensures that 0 to 5.5 V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5 V to 3 V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

### Features

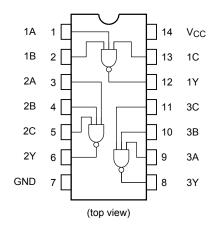
- High speed:  $t_{pd}$  = 3.9 ns (typ.) at V<sub>CC</sub> = 5 V
- Low power dissipation:  $I_{CC}$  = 2  $\mu A$  (max) at Ta = 25°C
- High noise immunity:  $V_{NIH} = V_{NIL} = 28\% V_{CC}$  (min)
- Power down protection is provided on all inputs.
- Balanced propagation delays:  $t_{pLH} \simeq t_{pHL}$
- Wide operating voltage range: VCC (opr) = 2 to 5.5 V
- Pin and function compatible with 74ALS10



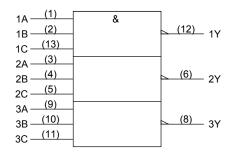
Downloaded from **Elcodis.com** electronic components distributor

## TOSHIBA

## **Pin Assignment**



### **IEC Logic Symbol**



#### **Truth Table**

А	В	С	Y
L	Х	Х	Н
Х	L	Х	Н
Х	Х	L	Н
н	Н	н	L

X: Don't care

## Absolute Maximum Ratings (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage range	V <sub>CC</sub>	-0.5 to 7.0	V
DC input voltage	V <sub>IN</sub>	-0.5 to 7.0	V
DC output voltage	Vout	-0.5 to V <sub>CC</sub> + 0.5	V
Input diode current	I <sub>IK</sub>	-20	mA
Output diode current	IOK	±20	mA
DC output current	I <sub>OUT</sub>	±25	mA
DC V <sub>CC</sub> /ground current	ICC	±50	mA
Power dissipation	PD	180	mW
Storage temperature	T <sub>stg</sub>	-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

## **Operating Ranges (Note)**

Characteristics	cteristics Symbol Rating		Unit	
Supply voltage	V <sub>CC</sub>	2.0 to 5.5	V	
Input voltage	V <sub>IN</sub>	V <sub>IN</sub> 0 to 5.5		
Output voltage	V <sub>OUT</sub> 0 to V <sub>CC</sub>		V	
Operating temperature	T <sub>opr</sub>	-40 to 85	°C	
Input rise and fall time	dt/dv	0 to 100 (V <sub>CC</sub> = 3.3 ± 0.3 V)	ns/V	
	ui/uv	0 to 20 (V <sub>CC</sub> = 5 $\pm$ 0.5 V)	115/ V	

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

## **Electrical Characteristics**

#### **DC Characteristics**

Characteristics	Symbol	Test Condition			Ta = 25°C			Ta = −40 to 85°C		Unit
				V <sub>CC</sub> (V)	Min	Тур.	Max	Min	Max	Offic
High-level input voltage	VIH	_			1.50 V <sub>CC</sub> × 0.7			1.50 V <sub>CC</sub> × 0.7	_	V
Low-level input voltage	VIL	_			_		0.50 V <sub>CC</sub> × 0.3	_	0.50 V <sub>CC</sub> × 0.3	V
High-level output voltage	V <sub>ОН</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -50 μA I <sub>OH</sub> = -4 mA	2.0 3.0 4.5 3.0	1.9 2.9 4.4 2.58	2.0 3.0 4.5 —		1.9 2.9 4.4 2.48		V
Low-level output voltage		V <sub>IN</sub> = V <sub>IH</sub>	l <sub>OH</sub> = -8 mA l <sub>OL</sub> = 50 μA	<ul><li>4.5</li><li>2.0</li><li>3.0</li><li>4.5</li></ul>	3.94 — — —	0.0 0.0 0.0		3.80 — — —		V
			I <sub>OL</sub> = 4 mA I <sub>OL</sub> = 8 mA	3.0 4.5	_		0.36 0.36		0.44 0.44	
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = 5.5 V or GND		0 to 5.5	_	_	±0.1	_	±1.0	μA
Quiescent supply current	ICC	V <sub>IN</sub> = V <sub>CC</sub> or GND		5.5	_	_	2.0	_	20.0	μA

#### AC Characteristics (input: tr = tf = 3 ns)

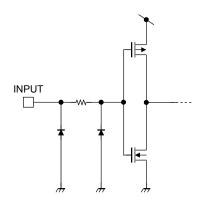
Characteristics	Symbol	Test Condition		Ta = 25°C			Ta = −40 to 85°C		Unit	
			V <sub>CC</sub> (V)	C <sub>L</sub> (pF)	Min	Тур.	Max	Min	Max	
Propagation delay time	t <sub>pLH</sub> t <sub>pHL</sub>	_	3.3 ± 0.3	15	_	5.7	8.4	1.0	10.0	- ns
				50	_	8.2	11.9	1.0	13.5	
			5.0 ± 0.5	15	_	3.9	5.9	1.0	7.0	
				50	_	5.4	7.9	1.0	9.0	
Input capacitance	C <sub>IN</sub>		—		_	4	10	—	10	pF
Power dissipation capacitance	C <sub>PD</sub>			(Note)		17	_		_	pF

Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/3$  (per gate)

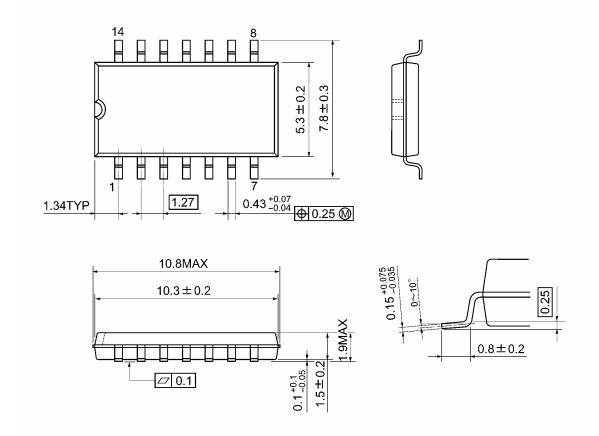
## Input Equivalent Circuit



## **Package Dimensions**

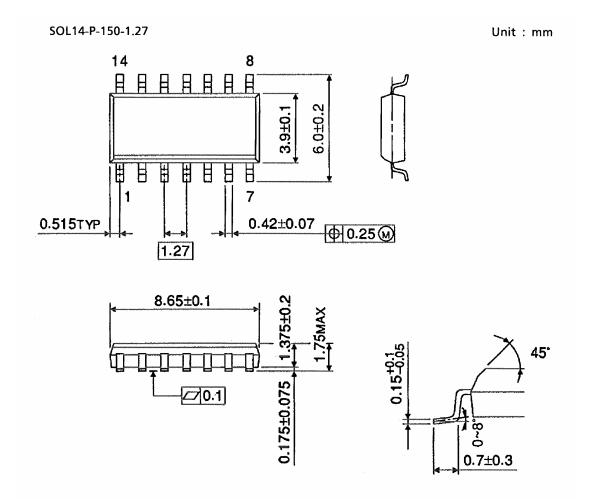
SOP14-P-300-1.27A

Unit: mm



Weight: 0.18 g (typ.)

## Package Dimensions (Note)



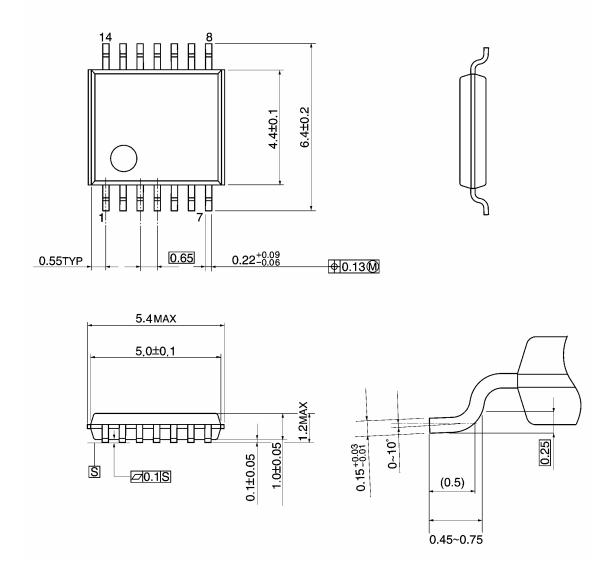
Note: This package is not available in Japan.

Weight: 0.12 g (typ.)

## **Package Dimensions**

TSSOP14-P-0044-0.65A

Unit: mm



Weight: 0.06 g (typ.) d

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20070701-EN GENERAL

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